Notice of References Cited Application/Control No. 10/521,316 Examiner PHILIPPE S. DERAKSHANI Applicant(s)/Patent Under Reexamination DUQUET ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,540,079	04-2003	Garcia et al.	222/107
*	В	US-2001/0009258	07-2001	Wakayama, Takahiro	222/105
*	С	US-6,637,623	10-2003	Muise et al.	222/105
*	D	US-5,069,359	12-1991	Liebel, Henry L.	229/117.3
*	E	US-2007/0023453	02-2007	Simkins, Nelson E.	222/214
*	F	US-4,958,748	09-1990	Otake, Masaaki	222/214
	G	US-			
	H.	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s				·	
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	υ					
	V					
	w					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.